

CAT523

Configured Digitally Programmable Potentiometer (DPP): Programmable Voltage Applications

FEATURES

- Two 8-bit DPPS Configured as Programmable Voltages in DAC-like Applications
- **■** Buffered Wiper Outputs
- Nonvolatile Wiper Storage
- Output voltage range includes both supply rails
- 2 independently addressable output wipers
- 1 LSB Accuracy, High Resolution
- Serial µP interface
- Single supply operation: 2.7V-5.5V
- Setting read-back without effecting outputs

APPLICATIONS

- Automated product calibration.
- Remote control adjustment of equipment
- Offset, gain and zero adjustments in Self-Calibrating and Adaptive Control systems.
- **■** Tamper-proof calibrations.
- DAC (with memory) substitute

DESCRIPTION

The CAT523 is a dual, 8-bit digitally-programmable potentiometer configured for programmable voltage and DAC-like applications. Intended for final calibration of products such as camcorders, fax machines and cellular telephones on automated high volume production lines, it is also well suited for systems capable of self calibration, and applications where equipment which is either difficult to access or in a hazardous environment, requires periodic adjustment.

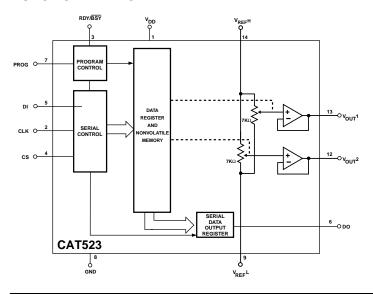
The 2 independently programmable DPPs have a common output voltage range which includes both supply rails. The wipers are buffered by rail to rail OP AMPS. Wiper settings, stored in non-volatile memory, are not lost when the device is powered down and are automatically reinstated when power is returned. Each wiper can be dithered to test new output values without

effecting the stored settings and stored settings can be read back without disturbing the DAC's output.

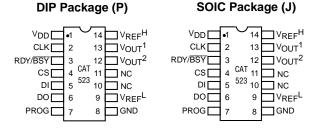
Control of the CAT523 is accomplished with a simple 3 wire serial interface. A Chip Select pin allows several CAT523's to share a common serial interface and communication back to the host controller is via a single serial data line thanks to the CAT523's Tri-Stated Data Output pin. A RDY/BSY output working in concert with an internal low voltage detector signals proper operation of non-volatile Erase/Write cycle.

The CAT523 is available in the 0 to 70° C Commercial and –40° C to + 85° C Industrial operating temperature ranges and offered in 14-pin plastic DIP and SOIC mount packages.

FUNCTIONAL DIAGRAM



PIN CONFIGURATION



CAT523 Advance Information

ABSOLUTE MAXIMUM RATINGS*

Supply Voltage V _{DD} to GND	0.5V to +7V
Inputs	
CLK to GND	$0.5V \text{ to } V_{DD} + 0.5V$
CS to GND	$0.5V \text{ to } V_{DD} + 0.5V$
DI to GND	$0.5V \text{ to } V_{DD} + 0.5V$
PROG to GND	$0.5V \text{ to } V_{DD} + 0.5V$
V _{REF} H to GND	$0.5V \text{ to } V_{DD} + 0.5V$
V _{REF} L to GND	$0.5V \text{ to } V_{DD} + 0.5V$
Outputs	
D ₀ to GND	$0.5V \text{ to } V_{DD} + 0.5V$
V _{OUT} 1– 4 to GND	$0.5V$ to $V_{DD} + 0.5V$
Operating Ambient Temperature	
Commercial ('C' suffix)	0°C to +70°C
Industrial ('I' suffix)	– 40°C to +85°C

Junction Temperature	+150°C
Storage Temperature	–65°C to +150°C
Lead Soldering (10 sec max)	+300°C

^{*} Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. Absolute Maximum Ratings are limited values applied individually while other parameters are within specified operating conditions, and functional operation at any of these conditions is NOT implied. Device performance and reliability may be impaired by exposure to absolute rating conditions for extended periods of time.

RELIABILITY CHARACTERISTICS

Symbol	Parameter	Min	Max	Units	Test Method
V _{ZAP} ⁽¹⁾	ESD Susceptibility	2000		Volts	MIL-STD-883, Test Method 3015
I _{LTH} ⁽¹⁾⁽²⁾	Latch-Up	100		mA JEDEC Standard 17	

NOTES: 1. This parameter is tested initially and after a design or process change that affects the parameter.

DC ELECTRICAL CHARACTERISTICS:

V_{DD} = +2.7 to +5.5V, V_{REF}H = V_{DD}, V_{REF}L = 0V, unless otherwise specified

Symbol Parameter Conditions Min

Symbol	Parameter	Conditions	Min	Тур	Max	Units
	Resolution		8	_	_	Bits
Accuracy						
INL	Integral Linearity Error	$I_{LOAD} = 10 \mu A, T_R = C$	_	_	± 1	LSB
		$T_R = I$	_	_	± 1	LSB
		$I_{LOAD} = 40 \mu A, T_R = C$	_	_	± 2	LSB
		$T_R = I$	_		± 2	LSB
DNL	Differential Linearity Error	$I_{LOAD} = 10 \mu A, T_R = C$	_		± 0.5	LSB
		$T_R = I$	_		± 0.5	LSB
		$I_{LOAD} = 40 \mu A, T_R = C$	_		± 1.5	LSB
		$T_R = I$	_	_	± 1.5	LSB

Logic Inputs

l _{IH}	Input Leakage Current	$V_{IN} = V_{DD}$	_	_	10	μΑ
I _{IL}	Input Leakage Current	$V_{IN} = 0V$	_		-10	μΑ
V _{IH}	High Level Input Voltage		2	_	V_{DD}	V
V _{IL}	Low Level Input Voltage		0	_	0.8	V
,			•			

V_{RH}	V _{REF} H Input Voltage Range	2.7	_	V_{DD}	V
V_{RL}	V _{REF} L Input Voltage Range	GND		V _{DD} -2.7	V
Z _{IN}	V _{REF} H–V _{REF} L Resistance	_	7k	_	Ω

V _{OH}	High Level Output Voltage	Ι _{ΟΗ} = – 40 μΑ	V _{DD} -0.3	_	_	V
V _{OL}	Low Level Output Voltage	$I_{OL} = 1 \text{ mA}, V_{DD} = +5V$	_	_	0.4	V
		$I_{OL} = 0.4 \text{ mA}, V_{DD} = +3V$	_	_	0.4	V

^{2.} Latch-up protection is provided for stresses up to 100mA on address and data pins from -1V to V_{CC} + 1V.

DC ELECTRICAL CHARACTERISTICS (Cont.):

 V_{DD} = +2.7V to +5.5V , $V_{REF}H$ = + V_{DD} , $V_{REF}L$ = 0V, unless otherwise specified

Symbol	Parameter Conditions		Min	Тур	Max	Units
Analog O	utput				'	
FSO	Full-Scale Output Voltage	$V_R = V_{REF}H - V_{REF}L$	0.99 V _R	0.995 V _R	_	V
ZSO	Zero-Scale Output Voltage	$V_R = V_{REF}H-V_{REF}L$	_	0.005 V _R	0.01 V _R	V
IL	DAC Output Load Current		_	_	1	μΑ
R _{OUT}	DAC Output Impedance	$V_{DD} = +5V$	_	_	100k	Ω
		$V_{DD} = +3V$	_	_	150k	Ω
PSSR	Power Supply Rejection	I _{LOAD} = 250 nA	_	_	1	LSB / V
Temperat	ure					
TCo	V _{OUT} Temperature Coefficient	$V_{REF}H = +5V, V_{REF}L = 0V$	_	_	200	μV/ °C
		V _{DD} = +5V, I _{LOAD} = 250nA				
TC _{REF}	Temperature Coefficient of	V _{REF} H to V _{REF} L	_	700	_	ppm / °C
	V _{REF} Resistance					
Power Su	pply					
I _{DD1}	Supply Current (Read)	Normal Operating	_	400	600	μΑ
I _{DD2}	Supply Current (Write)	V _{DD} =5V	_	1600	2500	μΑ
		V _{DD} =3V	_	1000	1600	μΑ
V_{DD}	Operating Voltage Range		2.7	_	5.5	V

AC ELECTRICAL CHARACTERISTICS:

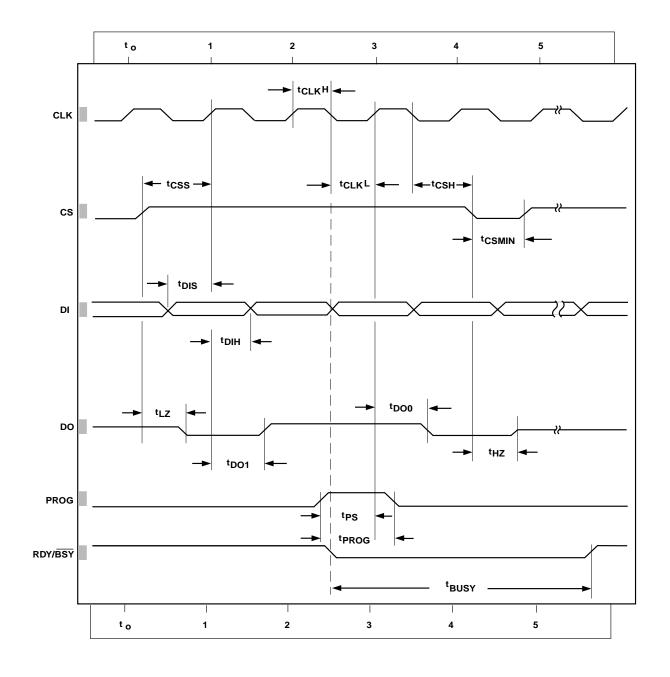
 V_{DD} = +2.7V to +5.5V, $V_{REF}H$ = + V_{DD} , $V_{REF}L$ = 0V, unless otherwise specified

Symbol	Parameter	Conditions		Тур	Max	Units
Digital				I.		1
t _{CSMIN}	Minimum CS Low Time		150	_	_	ns
t _{CSS}	CS Setup Time		100	_		ns
t _{CSH}	CS Hold Time		0	_	_	ns
t _{DIS}	DI Setup Time	$C_L = 100 \text{ pF},$	50	_	_	ns
t _{DIH}	DI Hold Time	see note 1	50	_	_	ns
t _{DO1}	Output Delay to 1		_	_	150	ns
t _{DO0}	Output Delay to 0		_	_	150	ns
t _{HZ}	Output Delay to High-Z		_	400	_	ns
t _{Busy}	Erase/Write Cycle Time		_	4	5	ms
t _{LZ}	Output Delay to Low-Z		_	400	_	ns
t _{PROG}	Erase/Write Pulse Width		700	_		ns
t _{PS}	PROG Setup Time		150	_	_	ns
t _{CLK} H	Minimum CLK High Time		500	_	_	ns
t _{CLK} L	Minimum CLK Low Time		300	_	_	ns
f _C	Clock Frequency		DC	_	1	MHz
Analog						
t _{DS}	DAC Settling Time to 1/2 LSB	$C_{LOAD} = 10 \text{ pF}, V_{DD} = +5V$	_	3	10	μs
		$C_{LOAD} = 10 \text{ pF}, V_{DD} = +3V$	_	6	10	μs
Pin Capac	itance					
C _{IN}	Input Capacitance	$V_{IN} = 0V, f = 1 \text{ MHz}^{(2)}$	_	8	_	pF
C _{OUT}	Output Capacitance	$V_{OUT} = 0V, f = 1 \text{ MHz}^{(2)}$	_	6	_	pF

NOTES: 1. All timing measurements are defined at the point of signal crossing V_{DD} / 2.

2. These parameters are periodically sampled and are not 100% tested.

A. C. TIMING DIAGRAM



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PIN DESCRIPTION

Pin	Name	Function
1	V_{DD}	Power supply positive.
2	CLK	Clock input pin.Clock input pin.
3	RDY/BSY	Ready/Busy Output
4	CS	Chip Select
5	DI	Serial data input pin.
6	DO	Serial data output pin.
7	PROG	EEPROM Programming Enable Input
8	GND	Power supply ground.
9	$V_{REF}L$	Minimum DAC output voltage.
10	NC	No Connect.
11	NC	No Connect.
12	V _{OUT} 2	DAC output channel 2.
13	V _{OUT} 1	DAC output channel 1.
14	$V_{REF}H$	Maximum DAC output voltage.

DAC addressing is as follows:

DAC OUTPUT	A0	A1
V _{OUT} 1	0	0
V _{OUT} 2	1	0

DEVICE OPERATION

The CAT523 is a quad 8-bit Digital to Analog Converter (DAC) whose outputs can be programmed to any one of 256 individual voltage steps. Once programmed, these output settings are retained in non-volatile EEPROM memory and will not be lost when power is removed from the chip. Upon power up the DACs return to the settings stored in EEPROM memory. Each DAC can be written to and read from independently without effecting the output voltage during the read or write cycle. Each output can also be temporarily adjusted without changing the stored output setting, which is useful for testing new output settings before storing them in memory.

DIGITAL INTERFACE

The CAT523 employs a standard 3 wire serial control interface consisting of Clock (CLK), Chip Select (CS) and Data In (DI) inputs. For all operations, address and data are shifted in LSB first. In addition, all digital data must be preceded by a logic "1" as a start bit. The DAC address and data are clocked into the DI pin on the clock's rising edge. When sending multiple blocks of information a minimum of two clock cycles is required between the last block sent and the next start bit.

Multiple devices may share a common input data line by selectively activating the CS control of the desired IC. Data Outputs (DO) can also share a common line because the DO pin is Tri-Stated and returns to a high impedance when not in use.

CHIP SELECT

Chip Select (CS) enables and disables the CAT523's read and write operations. When CS is high data may be

read to or from the chip, and the Data Output (DO) pin is active. Data loaded into the DAC control registers will remain in effect until CS goes low. Bringing CS to a logic low returns all DAC outputs to the settings stored in EEPROM memory and switches DO to its high impedance Tri-State mode.

Because CS functions like a reset the CS pin has been equipped with a 30 ns to 90 ns filter circuit to prevent noise spikes from causing unwanted resets and the loss of volatile data.

CLOCK

The CAT523's clock controls both data flow in and out of the IC and EEPROM memory cell programming. Serial data is shifted into the DI pin and out of the DO pin on the clock's rising edge. While it is not necessary for the clock to be running between data transfers, the clock must be operating in order to write to EEPROM memory, even though the data being saved may already be resident in the DAC control register.

No clock is necessary upon system power-up. The CAT523's internal power-on reset circuitry loads data from EEPROM to the DACs without using the external clock.

As data transfers are edge triggered clean clock transitions are necessary to avoid falsely clocking data into the control registers. Standard CMOS and TTL logic families work well in this regard and it is recommended that any mechanical switches used for breadboarding or device evaluation purposes be debounced by a flip-flop or other suitable debouncing circuit.

VREF

 V_{REF} , the voltage applied between pins V_{REF} Hand V_{REF} L, sets the DAC's Zero to Full Scale output range where V_{REF} L = Zero and V_{REF} H = Full Scale. V_{REF} can span the full power supply range or just a fraction of it. In typical applications V_{REF} H and V_{REF} L are connected across the power supply rails. When using less than the full supply voltage V_{REF} H is restricted to voltages between V_{DD} and $V_{DD}/2$ and V_{REF} L to voltages between GND and $V_{DD}/2$.

READY/BUSY

When saving data to non-volatile EEPROM memory, the Ready/Busy ouput (RDY/BSY) signals the start and duration of the EEPROM erase/write cycle. Upon receiving a command to store data (PROG goes high) RDY/BSY goes low and remains low until the programming cycle is complete. During this time the CAT523 will ignore any data appearing at DI and no data will be output on DO.

RDY/ \overline{BSY} is internally ANDed with a low voltage detector circuit monitoring V_{DD}. If V_{DD} is below the minimum value required for EEPROM programming, RDY/ \overline{BSY} will remain high following the program command indicating a failure to record the desired data in non-volatile memory.

DATA OUTPUT

Data is output serially by the CAT523, LSB first, via the Data Out (DO) pin following the reception of a start bit and two address bits by the Data Input (DI). DO becomes active whenever CS goes high and resumes its high impedance Tri-State mode when CS returns low. Tri-Stating the DO pin allows several 523s to share a single serial data line and simplifies interfacing multiple 523s to a microprocessor.

WRITING TO MEMORY

Programming the CAT523's EEPROM memory is ac-

complished through the control signals: Chip Select (CS) and Program (PROG). With CS high, a start bit followed by a two bit DAC address and eight data bits are clocked into the DAC control register via the DI pin. Data enters on the clock's rising edge. The DAC output changes to its new setting on the clock cycle following D7, the last data bit.

Programming is achieved by bringing PROG high for a minimum of 3 ms. PROG must be brought high sometime after the start bit and at least 150 ns prior to the rising edge of the clock cycle immediately following the D7 bit. Two clock cycles after the D7 bit the DAC control register will be ready to receive the next set of address and data bits. The clock must be kept running throughout the programming cycle. Internal control circuitry takes care of ramping the programming voltage for data transfer to the EEPROM cells. The CAT523's EEPROM memory cells will endure over 100,000 write cycles and will retain data for a minimum of 100 years without being refreshed.

READING DATA

Each time data is transferred into a DAC control register currently held data is shifted out via the D0 pin, thus in every data transaction a read cycle occurs. Note, however, that the reading process is destructive. Data must be removed from the register in order to be read. Figure 2 depicts a Read Only cycle in which no change occurs in the DAC's output. This feature allows μPs to poll DACs for their current setting without disturbing the output voltage but it assumes that the setting being read is also stored in EEPROM so that it can be restored at the end of the read cycle. In Figure 2 CS returns low before the 13^{th} clock cycle completes. In doing so the EEPROM's setting is reloaded into the DAC control register. Since



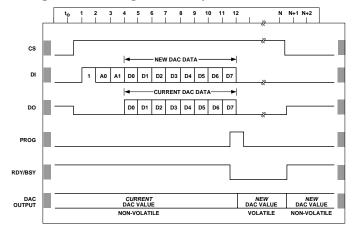
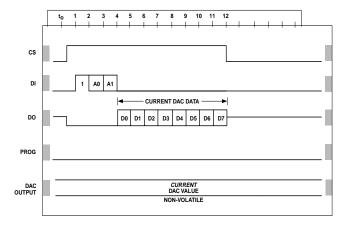


Figure 2. Reading from Memory



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this value is the same as that which had been there previously no change in the DAC's output is noticed. Had the value held in the control register been different from that stored in EEPROM then a change would occur at the read cycle's conclusion.

TEMPORARILY CHANGE OUTPUT

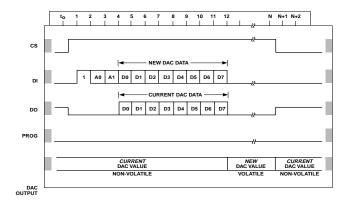
The CAT523 allows temporary changes in DAC's output to be made without disturbing the settings retained in EEPROM memory. This feature is particularly useful when testing for a new output setting and allows for user adjustment of preset or default values without losing the original factory settings.

Figure 3 shows the control and data signals needed to effect a temporary output change. DAC settings may be changed as many times as required and can be made to any of the four DACs in any order or sequence. The temporary setting(s) remain in effect long as CS remains high. When CS returns low all four DACs will return to the output values stored in EEPROM memory.

When it is desired to save a new setting acquired using

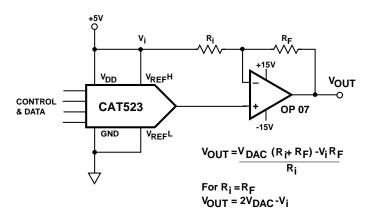
this feature, the new value must be reloaded into the DAC control register prior to programming. This is because the CAT523's internal control circuitry discards the new data from the programming register two clock cycles after receiving it (after reception is complete) if no PROG signal is received.

Figure 3. Temporary Change in Output

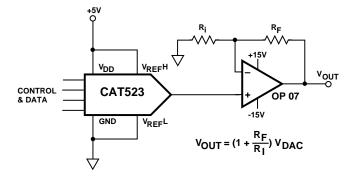


APPLICATION CIRCUITS

DAC	INPUT	DAC OUTPUT	ANALOG OUTPUT
		$V_{DAC} = \frac{CODE}{255} (V_{FS} - V_{ZERO}) + V_{ZERO}$ $V_{FS} = 0.99 V_{REF}$	V _{REF} = 5V
MSB	LSB	V _{ZERO} = 0.01 V _{REF}	R _I =R _F
1111	1111	255 (.98 V _{REF}) + .01 V _{REF} = .990 V _{REF}	V _{OUT} = +4.90V
1000	0000	128 (.98 V _{REF}) + .01 V _{REF} = .502 V _{REF}	V _{OUT} = +0.02V
0111	1111	$\frac{127}{255}$ (.98 V _{REF}) + .01 V _{REF} = .498 V _{REF}	V _{OUT} = -0.02V
0000	0001	$\frac{1}{255}$ (.98 V _{REF}) + .01 V _{REF} = .014 V _{REF}	V _{OUT} = -4.86V
0000	0000	$\frac{0}{255}$ (.98 V _{REF}) + .01 V _{REF} = .010 V _{REF}	V _{OUT} = -4.90V

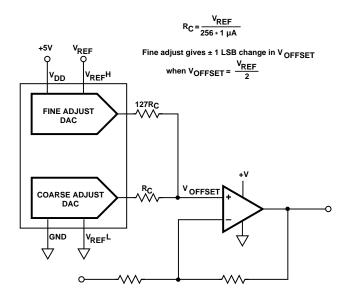


Bipolar DAC Output

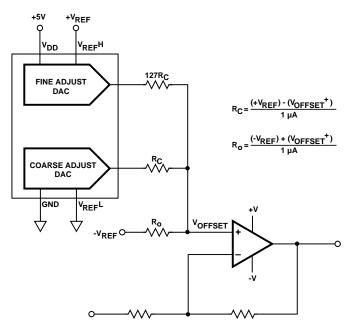


Amplified DAC Output

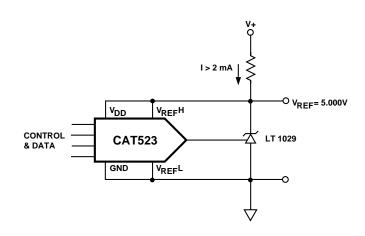
APPLICATION CIRCUITS (Cont.)



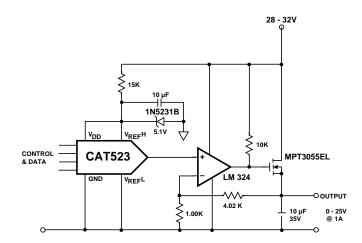
Coarse-Fine Offset Control by Averaging DAC Outputs for Single Power Supply Systems



Coarse-Fine Offset Control by Averaging DAC Outputs for Dual Power Supply Systems



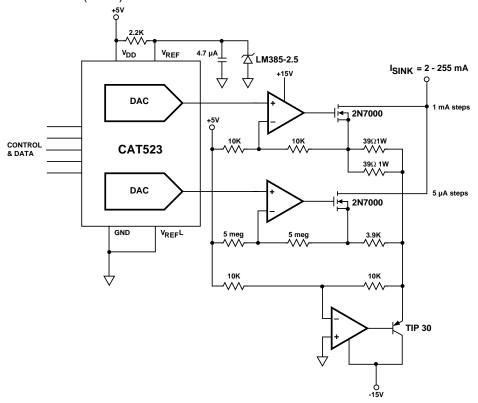
Digitally Trimmed Voltage Reference



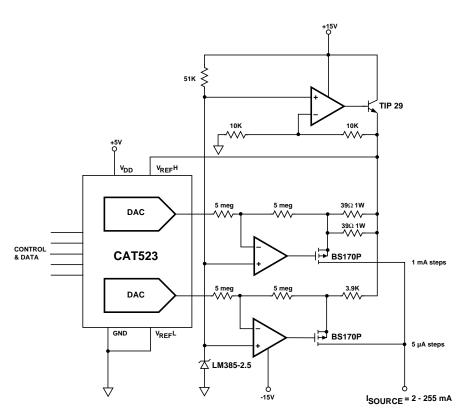
Digitally Controlled Voltage Reference

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APPLICATION CIRCUITS (Cont.)

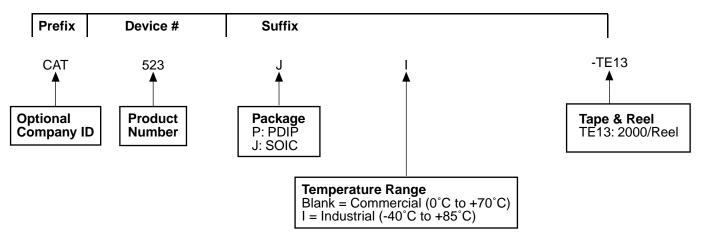


Current Sink with 4 Decades of Resolution



Current Source with 4 Decades of Resolution

ORDERING INFORMATION



Notes:

(1) The device used in the above example is a CAT523JI-TE13 (SOIC, Industrial Temperature, Tape & Reel)